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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/624,860	CHAN ET AL.	
Examiner	Art Unit	
Peter Coughlan	2120	

	SEARCHED		
Class	Subclass	Date	Examiner
706	45	12/13/2006	PDC
706	13	12/13/2006	PDC
706	61	12/13/2006	PDC
709	205	12/13/2006	PDC
705	35	12/13/2006	PDC
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
Eastdetermination, exception, error, software, hardware, framework, database, components, repository, methodology	12/13/2006	PDC
EastII object, technology, classes, identify, interface, communication, provide, supply, template, business object	12/13/2006	PDÇ
EastIIItechnology objects, parameters, design. solution, widget, rules, faric, server, client, questions, interview,	12/13/2006	PDC
IEEEsolution management, business objects, technology objects, classes, interface, parameters, client, server, solution,	12/13/2006	PDC
InventorsClaribel Chan, David Cheng Hu, Tim Landvoigt, Charles Nelson, James Tarver	12/13/2006	PDC